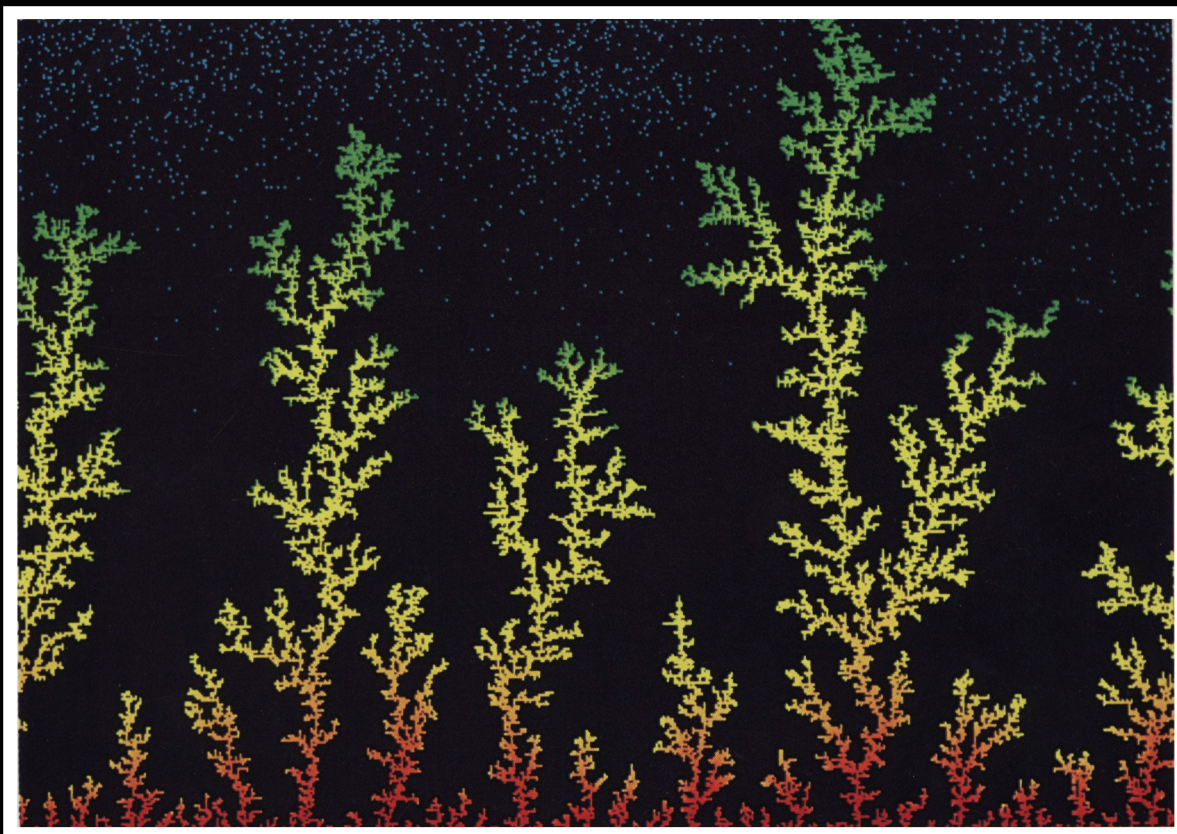


MRS BULLETIN

Materials Research Society Vol. XI No. 1 January/February 1986

1986: LOOKING AHEAD



Journal of Materials Research Nears Publication

President Pike: Where Do We Go From Here?

E-MRS Meeting In Strasbourg

MSE Study Charts Objectives

Spring Meeting in Palo Alto

REFLECTIONS ON 1985
Boston Meeting: The Best Yet
The Year in Review

RBS SURFACE ANALYZER LOOK INTO IT!

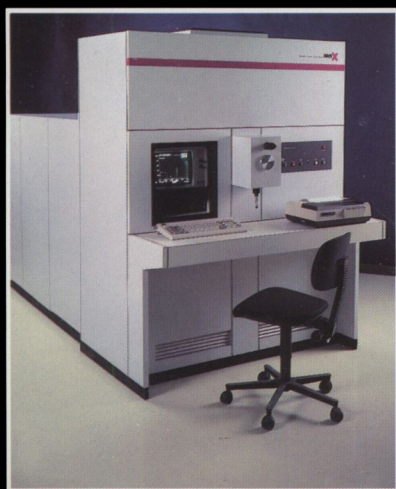
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Fratral computer model of diffusion limited aggregation as a prototype for dendritic growth on a surface during electrodeposition. Photo courtesy of R. F. Voss, IBM T. J. Watson Research Center

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